Search Notes								

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/511,441	MARUYAMA ET AL.	
Examiner	Art Unit	
Diane Yabut	3734	

	SEAR	CHED	
Class	Subclass	Date	Examiner
606	144	12/7/2006	DY
606	139	12/7/2006	DY
606	148	12/7/2006	DY
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT)
	DATE	EXMR
EAST Search see attached Search History	12/7/2006	DY
Consulted with primary Julian Woo on class/subclass saerch	12/7/2006	DY